Unit: mm

TOSHIBA Transistor Silicon NPN Epitaxial Planar Type

# MT3S07T

#### VHF~UHF Band Low Noise Amplifier Applications

- Low noise figure: NF = 1.5dB (V<sub>CE</sub> = 3 V, I<sub>C</sub> = 5 mA, f = 2 GHz)
- High gain:  $|S_{21e}|^2 = 9.5$ dB (V<sub>CE</sub> = 3 V, I<sub>C</sub> = 15 mA, f = 2 GHz)

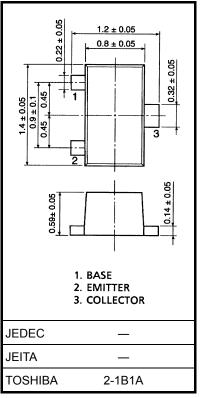
#### Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Collector-base voltage	V <sub>CBO</sub>	10	V
Collector-emitter voltage	V <sub>CEO</sub>	5	V
Emitter-base voltage	V <sub>EBO</sub>	1.5	V
Collector current	ΙC	25	mA
Base current	Ι <sub>Β</sub>	10	mA
Collector power dissipation	PC	100	mW
Junction temperature	Tj	125	°C
Storage temperature range	T <sub>stg</sub>	-55~125	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling

Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



Weight: 0.0022 g (typ.)

#### Marking



## Microwave Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Transition frequency	f <sub>T</sub>	$V_{CE} = 3 V, I_{C} = 10 mA$	10	12	_	GHz
Insertion dain	S <sub>21e</sub>   <sup>2</sup> (1)	$V_{CE} = 1 \text{ V}, \text{ I}_{C} = 5 \text{ mA}, \text{ f} = 2 \text{ GHz}$	_	7.5		dB
	S <sub>21e</sub>   <sup>2</sup> (2)	$V_{CE} = 3 \text{ V}, \text{ I}_{C} = 15 \text{ mA}, \text{ f} = 2 \text{ GHz}$	6.5	9.5		
Noise figure	NF (1)	$V_{CE} = 1 \text{ V}, \text{ I}_{C} = 5 \text{ mA}, \text{ f} = 2 \text{ GHz}$	_	1.6	3	dB
	NF (2)	$V_{CE} = 3 V, I_{C} = 5 mA, f = 2 GHz$	_	1.5	3	uD

### **Electrical Characteristics (Ta = 25°C)**

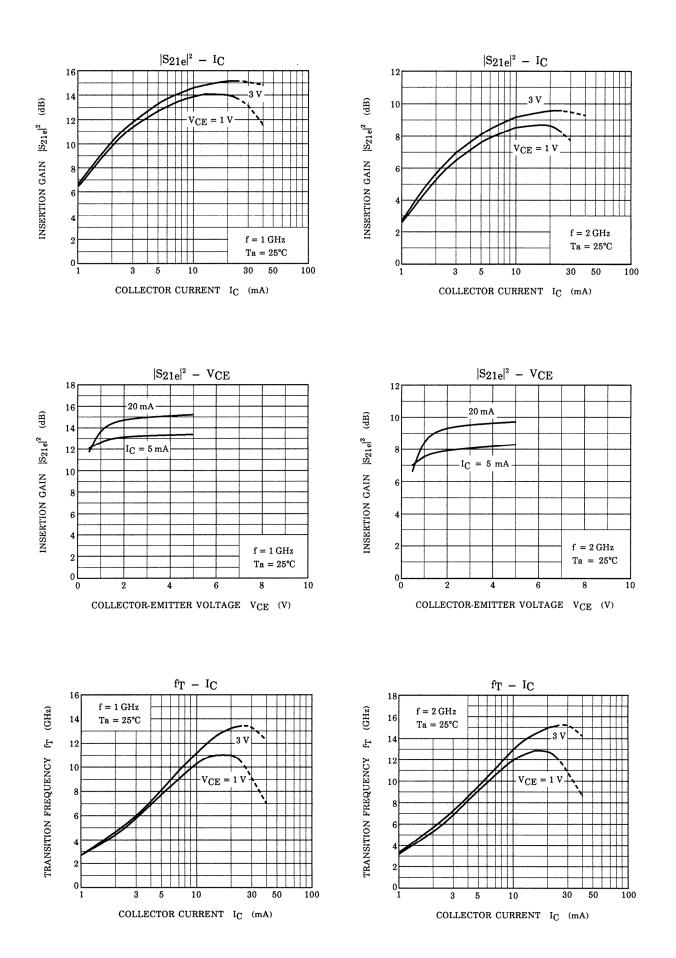
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	$V_{CB} = 5 \text{ V}, \text{ I}_{E} = 0$	—	—	0.1	μA
Emitter cut-off current	I <sub>EBO</sub>	$V_{EB} = 1 \text{ V}, \text{ I}_{C} = 0$	_	_	1	μA
DC current gain	h <sub>FE</sub>	$V_{CE} = 1 \text{ V}, \text{ I}_{C} = 5 \text{ mA}$	70	_	140	
Reverse transfer capacitance	C <sub>re</sub>	$V_{CB} = 1 \text{ V}, \text{ I}_{E} = 0, \text{ f} = 1 \text{ MHz} \qquad (\text{Note})$	_	0.4	0.85	pF

Note: Cre is measured by 3 terminal method with capacitance bridge.

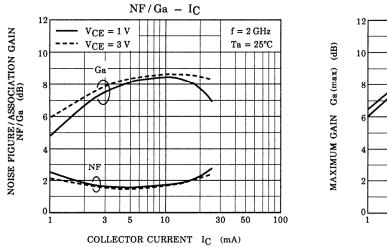
#### Caution

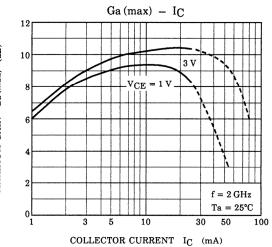
This device is sensitive to electrostatic discharge. Please handle with caution.

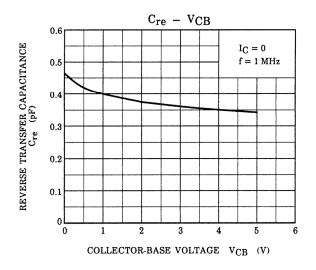
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20070701-EN GENERAL

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